Notice of References Cited Application/Control No. 10/797,953 Examiner SHANTELL HEIBER Applicant(s)/Patent Under Reexamination NIEMELA, KARI Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0191017	12-2002	Sinclair et al.	345/740
*	В	US-2006/0165027	07-2006	Heden, Karin	370/328
	O	US-			
	ם	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-		1	
	_	US-			
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р		A			
	q					
6	R					
	s					
	I				100	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.